Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination TANAYA ET AL. | Examiner | Art Unit | Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,194,817 B1	02-2001	Yachi et al.	310/370
*	В	US-5,861,705 A	01-1999	Wakatsuki et al.	310/370
*	С	US-4,410,827	10-1983	Kogure, Shigeru	310/370
*	D	US-6,791,243 B2	09-2004	Kawashima, Hirofumi	310/370
*	E	US-6,700,313 B2	03-2004	Dalla Piazza et al.	310/370
*	F	US-6,791,243 B2	09-2004	Kawashima, Hirofumi	310/370
*	G	US-4,384,232	05-1983	Debely, Pierre	310/370
*	Н	US-2002/0125794 A1	09-2002	Tanaya et al.	310/323.06
*	ı	US-6,724,271 B2	04-2004	Sakata et al.	331/156
*	j	US-6,587,009 B2	07-2003	Kitamura et al.	331/158
	К	US-			
	٦	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	z	JP-2001-235331	08-2001	Japan	Tsukasa et al. (abs)	G01C 19/56
	0					
	P					
	œ					
	R					
	S					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
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	х	

^{*}A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.